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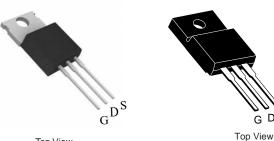
# N-Channel 650-V (D-S) Super Junction MOSFET

PRODUCT SUMMARY					
$V_{DS}$ (V) at $T_J$ max.	650				
R <sub>DS(on)</sub> max. (Ω) at 25 °C	$V_{GS} = 10 V$	0.19			
Q <sub>g</sub> max. (nC)	106				
Q <sub>gs</sub> (nC)	14				
Q <sub>gd</sub> (nC)	33				
Configuration	Single				



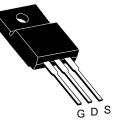


#### TO-220 Pin Configuration



Top View

TO-220 FULLPAK



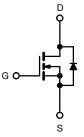
### **FEATURES**

- Reduced t<sub>rr</sub>, Q<sub>rr</sub>, and I<sub>RRM</sub>
- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Low switching losses due to reduced Q<sub>rr</sub>
- Ultra low gate charge (Q<sub>q</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Telecommunications
  - Server and telecom power supplies
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- · Consumer and computing - ATX power supplies
- Industrial
  - Welding
  - Battery chargers
- Renewable energy
  - Solar (PV inverters)
- Switch mode power supplies (SMPS)





Top View

N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> ( $T_c = 25 \degree C$ , unless otherwise noted)									
PARAMETER			SYMBOL	LIMIT	UNIT				
Drain-Source Voltage			V <sub>DS</sub>	650	V				
Gate-Source Voltage			V <sub>GS</sub>	± 30	v				
Continuous Drain Current (T <sub>J</sub> = 150 °C)	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	- I <sub>D</sub>	20					
	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C		13	А				
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	53					
Linear Derating Factor				1.7	W/°C				
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	367	mJ				
Maximum Power Dissipation			P <sub>D</sub>	208	W				
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C				
Drain-Source Voltage Slope	T <sub>J</sub> = 125 °C		d)//dt	37	1//22				
Reverse Diode dV/dt <sup>d</sup>		dV/dt	31	V/ns					
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s			300	°C				

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD} = 50$  V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 5.1 A.

c. 1.6 mm from case.

d.  $I_{SD} \leq I_D$ , dl/dt = 100 A/µs, starting T<sub>J</sub> = 25 °C.



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THERMAL RESISTANCE RAT	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62				
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 0.5				°C/W		
SPECIFICATIONS (T_J = 25 $^\circ C,\iota$	unless otherwi	se noted)						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static								
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> :	= 0 V, I <sub>D</sub> =	250 µA	650	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.67	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>	V <sub>DS</sub> =	= V <sub>GS</sub> , I <sub>D</sub> =	250 µA	2	-	4	V
Cata Cauraa Laakaga	V <sub>GS</sub> = ± 20 V		V	-	-	± 100	nA	
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 30 V		-	-	± 1	μA	
Zero Gate Voltage Drain Current	1	V <sub>DS</sub> =	= 520 V, V <sub>0</sub>	<sub>as</sub> = 0 V	-	-	1	μA
	IDSS	V <sub>DS</sub> = 520 \	$V_{\rm GS} = 0$	V, T <sub>J</sub> = 125 °C	-	-	500	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		<sub>D</sub> = 11 A	-	0.19	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub>	= 30 V, I <sub>D</sub>	= 11 A	-	7.0	-	S
Dynamic	*				•	•	•	•
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 \	1	-	2322	-	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 100 V,$ f = 1 MHz		-	105	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	4	-		
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>	$V_{DS}$ = 0 V to 520 V, $V_{GS}$ = 0 V		-	84	-		
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>			-	293	-		
Total Gate Charge	Qg				-	71	106	1
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V I <sub>D</sub> = 11 A, V <sub>DS</sub> = 520 V		-	14	-	nC	
Gate-Drain Charge	Q <sub>gd</sub>			-	33	-		
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 520 V, I <sub>D</sub> = 11 A,		-	22	44	-	
Rise Time	t <sub>r</sub>			-	34	68		
Turn-Off Delay Time	t <sub>d(off)</sub>		$V_{GS} = 10 \text{ V}, \text{ R}_{g} = 9.1 \Omega$		-	68	102	ns
Fall Time	t <sub>f</sub>	-		-	42	84	1	
Gate Input Resistance	R <sub>g</sub>	f = 1 MHz, open drain		-	0.78	-	Ω	
Drain-Source Body Diode Characteristi		-			•			
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	MOSFET symbol showing the		-	-	21	A	
Pulsed Diode Forward Current	I <sub>SM</sub>	integral reverse p - n junction diode			-	-		53
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 11 A, V <sub>GS</sub> = 0 V			-	0.9	1.2	V
Reverse Recovery Time	t <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = I_S = 11 \text{ A},$ dI/dt = 100 A/µs, V <sub>R</sub> = 25 V		-	160	-	ns	
Reverse Recovery Charge	Q <sub>rr</sub>			-	1.2	-	μC	
Reverse Recovery Current	I <sub>RRM</sub>			_	14	-	A	

Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



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### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

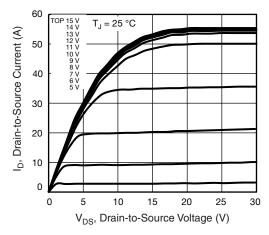


Fig. 1 - Typical Output Characteristics

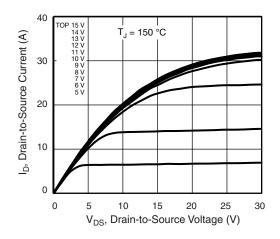


Fig. 2 - Typical Output Characteristics

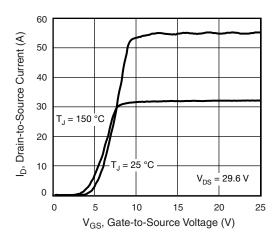


Fig. 3 - Typical Transfer Characteristics

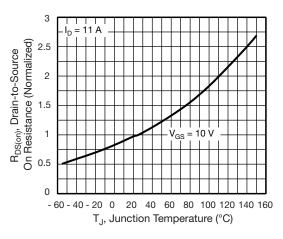


Fig. 4 - Normalized On-Resistance vs. Temperature

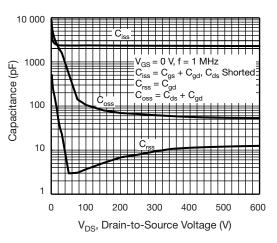


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

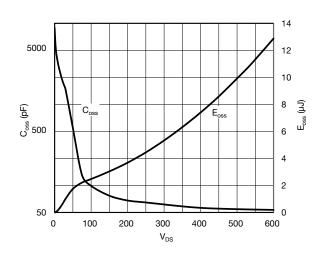


Fig. 6 - C<sub>oss</sub> and E<sub>oss</sub> vs. V<sub>DS</sub>



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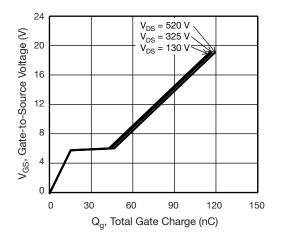


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

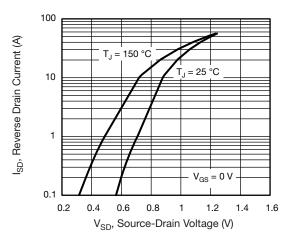


Fig. 8 - Typical Source-Drain Diode Forward Voltage

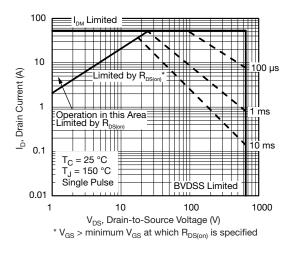


Fig. 9 - Maximum Safe Operating Area

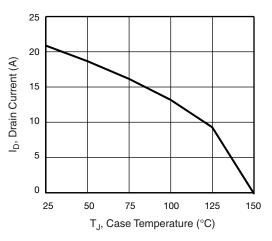


Fig. 10 - Maximum Drain Current vs. Case Temperature

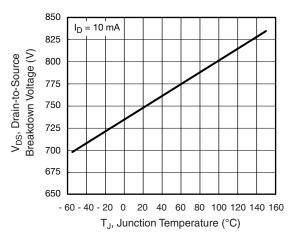


Fig. 11 - Temperature vs. Drain-to-Source Voltage



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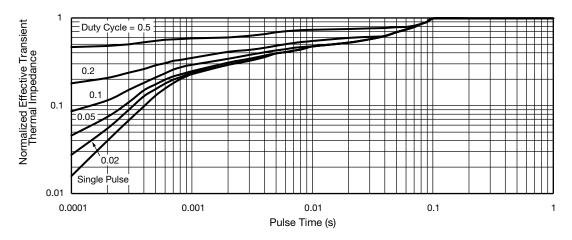


Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case

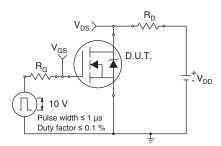


Fig. 13 - Switching Time Test Circuit

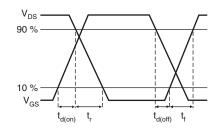


Fig. 14 - Switching Time Waveforms

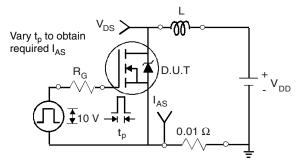


Fig. 15 - Unclamped Inductive Test Circuit

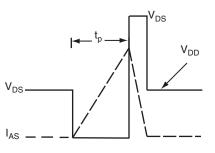


Fig. 16 - Unclamped Inductive Waveforms

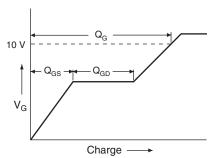


Fig. 17 - Basic Gate Charge Waveform

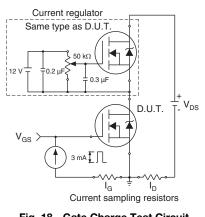
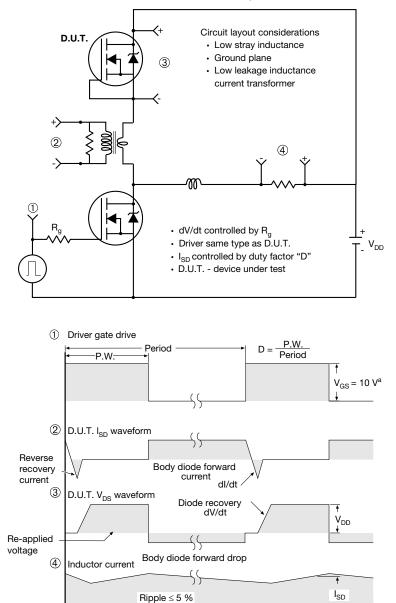


Fig. 18 - Gate Charge Test Circuit



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#### Peak Diode Recovery dV/dt Test Circuit

Note a.  $V_{GS} = 5$  V for logic level devices

Fig. 19 - For N-Channel



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